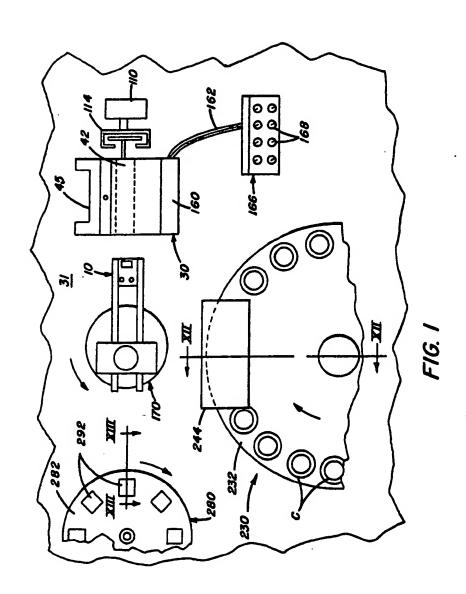
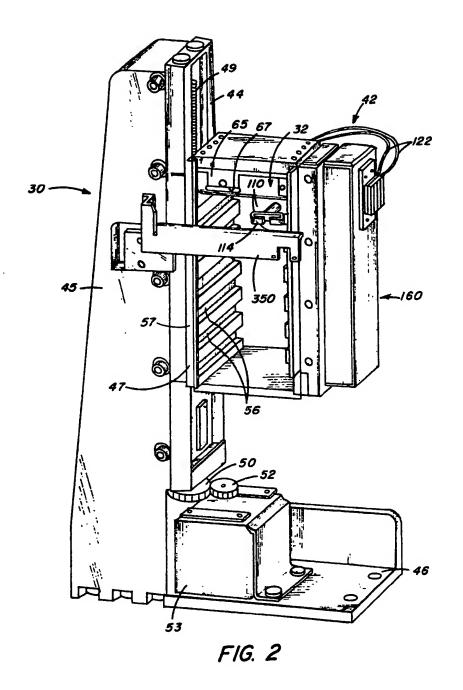
# (12) UK Patent Application (19) GB (11) 2001443

- (21) Application No 7830909
- (22) Date of filing 24 Jul 1978
- (23) Claims filed 24 Jul 1978
- (30) Priority data
- (31) 818255
- (32) 22 Jul 1977
- (33) United States of America (US)
- (43) Application published 31 Jan 1979
- (51) INT CL2 GO1N 27/00 21/00
- (52) Domestic classification G1N 25B 25C4A 25D1 25DX BKT G1A A4 C2 FG G14 G6 G7 R7 T20 T23 T2
- (56) Documents cited GB 1485506 GB 1461319 GB 1424823 GB 1401227 GB 1381514 GB 1335483 GB 1321754 **GB 1218745**
- (58) Field of Search G1A **G18**
- G1N (71) Applicant Eastman Kodak Company 343 State Street Rochester New York 14650 United States of America
- (72) Inventors PAUL NICHOLAS **SCHNIPELSKY RAYMOND FRANCIS JAKUBOWICZ DONALD EUGE** LARSON
- (74) Agents L A Trangmar BSc CPA

(54) Testing apparatus for analysis ing electrode impedance. of liquid samples

(57) In apparatus for analysis of liquids of the type which uses disposable discrete analyte dedicated substrates incorrect results arising if the substrate is inoperable through being defective or dedicated to a different analyte from that being measured, are avoided by combining the response measuring means used to monitor the response of the substrates to applied analyte samples with testing means adapted to distinguish defective substrates or wrongly dedicated substrates and initiate their removal. Defective substrates may be detected by failure to react with analyte and a resulting absence of differential signal and wrongly dedicated substrates comprising electrodes may be detected by measur-





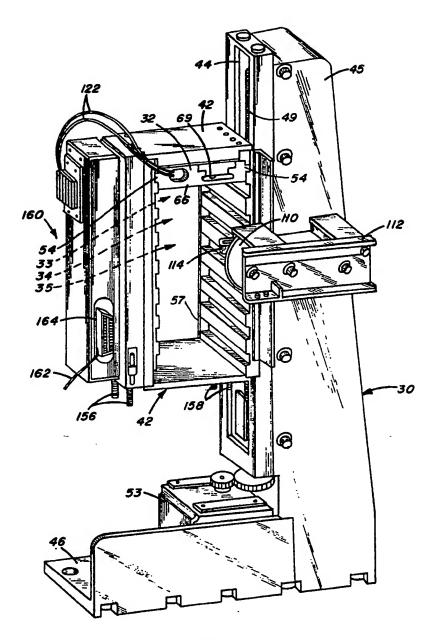
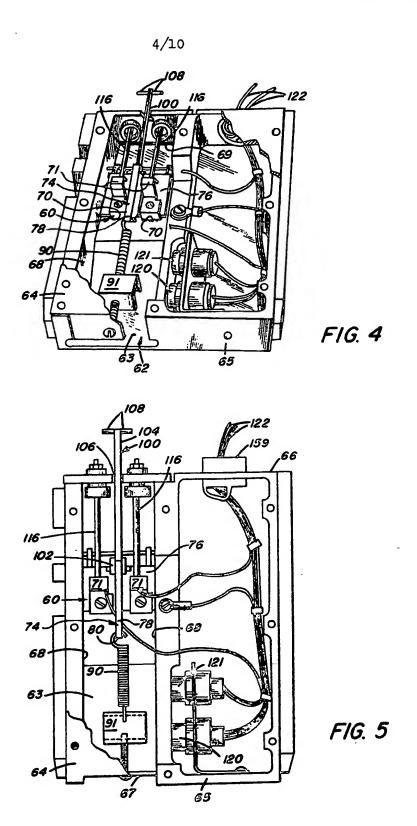
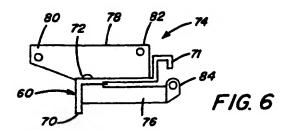
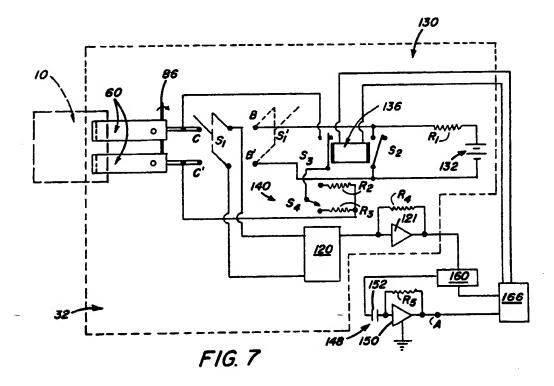


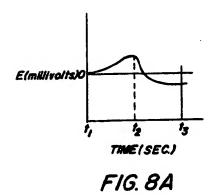
FIG. 3











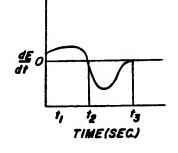
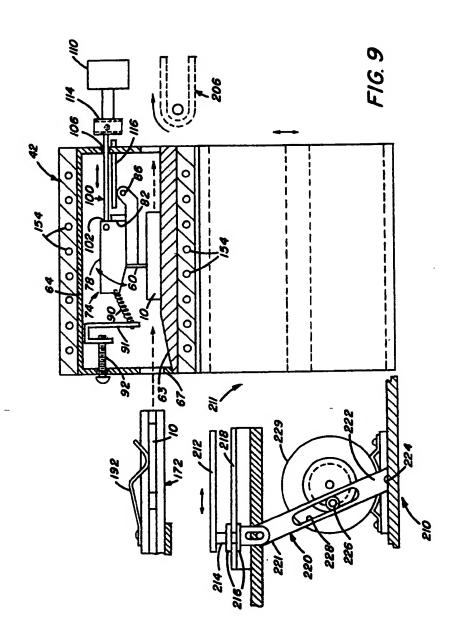
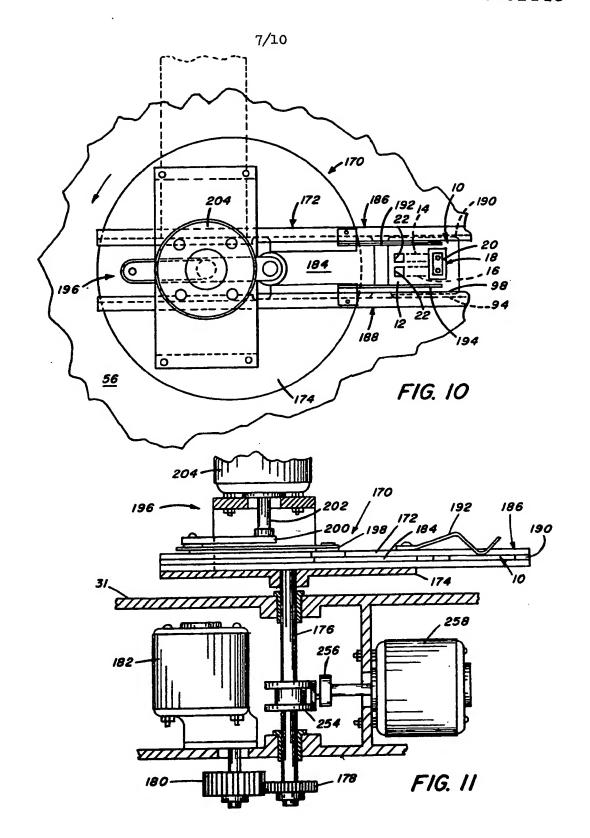
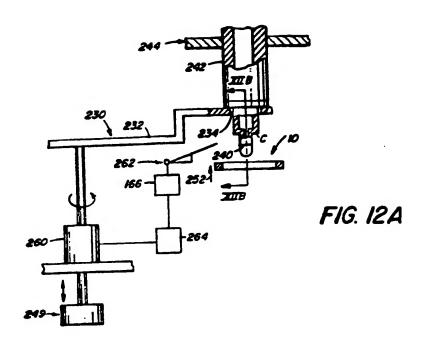


FIG. 8B







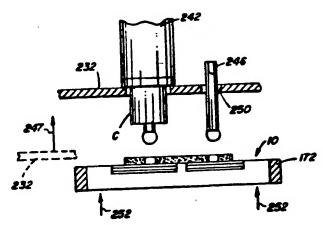
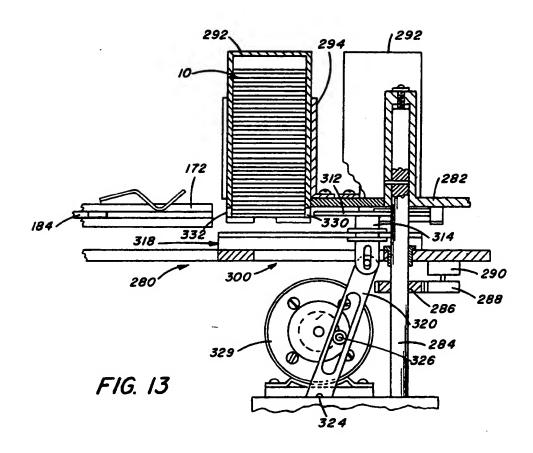
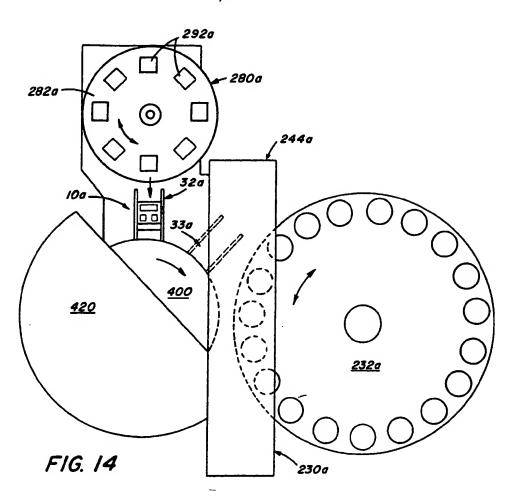
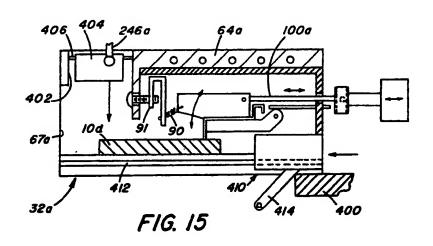


FIG. 12B



10/10





### **SPECIFICATION**

# Apparatus f r analysis of liquid samples

5 The present invention relates to apparatus for detecting the level of various analytes in liquids such as body fluids. Apparatus of this type is commonly known as a clinical analyzer.

O Clinical analyzers have been developed to permit analysis of body fluids, such as blood serum, whereby physicians can both detect and measure the amount of various analytes whose presence or level may be used to assist

15 diagnosis of body malfunction or disease. Such liquids, if added to appropriate reagents, which can be either in a liquid or in a dried, coated form generate a signal, for example in the form of a colour change or fluorescence.

20 Detection of such radiation signals after a suitable incubation period is usually done in a single station as a final step. Generally such analysis is called radiometric detection. Alternatively, certain ionic blood components are

25 detected electrically by a potentiometer using the potentials generated by ion selective electrodes, hereinafter ISE's. Included in such tests are the amounts of chloride, sodium and potassium ions. Whether the test is poten-30 tiometric or radiometric, it relies upon a sub-

strate to generate a signal of the respective kinds described, in the presence of the test component of the biological liquid.

Recent innovations have provided ISE's in 35 essentially planar, dried form, suitable for use in pairs in an analyzer. Examples are described in Research Disclosure Issue 161 September 1977, Item No. 16113 entitled "lon-Selective Electrode" and U.S. Patent No.

40 4,053,381 "Device and Method for Determining Ionic Activity and Components of Liquid Drops". Although remarkable accuracy is achievable by such devices, it has been discovered that occasionally the paired electrodes

45 are shorted together, and therefore use less for testing for ion activity. Ion selective electrodes, by their nature, are dedicated to the measurement of a single ion. A pair of ISE's designed for testing for chloride ions however

50 could be assigned erroneously for testing for sodium ions for example giving faulty output. Such defects and errors can occur even with good quality control in manufacturing. When a defective or erroneous substrate is used, the

55 problem is detected, if at all, in the analyzers of the prior art only when the read station is reached, necessitating that the whole test be repeated. If the wrong type of ISE substrate has been used, it is possible that the error

60 might not be detected at all so that a false result is reported. In any ev nt, the container from which the sample in question was drawn for analysis generally might no length be available, in which case a new blood sample 65 must be drawn from the patient to repeat the

test with a new substrat.

Yet another pr blem which can exist in som s lid electr d s is a differential rate of equilibrium arising out of a nonuniformity of coating thickness and chemistry. That is, with some electrodes it is not possible to predict that a steady-state equilibrium will be reached in all cases in x minutes, unless "x" is selected to be as long as the longest possibl time. An arbitrary selection of a large valu of "x" results in wasted throughput time compared to what would be available if individual equilibrium times were known.

Defective substrates can also occur in radiometric analyzers, which as noted above rely upon a single photometer or colorimeter to read each substrate at the end of a test. For example, insufficient or incorrect chemicals may have been added to form the substrate.

Such a problem will be detected, if at all, only when the single read station, hereinafter called "single channel", is finally reached, necessitating the retrieval of another blood sample from the patient to repeat the test. As with ion selective electrodes, the substrates used in radiometric analysers are normally dedicat d to a single analyte.

Single channel analyzers of the type described above inherently require the read station to be last, because any attempt to place the read station earlier in the sequence would cause all other test samples to be delay d for n times t minutes, where n is the number f substrates to be read and t is the duration for the incubation period. The through-put of the machine would be greatly delayed bey not that which is economically practical.

The analyzer disclosed in United Stat s Patent No. 3,832,135 is an example of the radiometric analyzers described above. Although there are a plurality of radiometric in that analyzer, there is only one radiometer for each test, so that on a test-by-test basis, it provides only a single channel read-out.

In the Centria system of Union Carbid

described in Clinical Chemistry, Volum 21, No. 9, page 1305 (1975), through-put is increased by using three detection stations for radioactive immunoassays. This system fails to utilize such multiple stations to provide early detection of possibly erroneous substrat s, in part because an intermediate process st p (centrifuge separation) prevents such early detection. That is, after the sample is added to the reagent it is transferred into an interm diate incubator/separator (I/S) station, aft r which the I/S stations are manually moved to a reader module that contains the detection stations. Furthermore, there is not even any appreciati n that such early detection is desir-

able r could av id errors.

Scintillation counters for the analysis of radioactive samples have been dev loped with multichannel read-out, as shown for xample in U.S. Patent No. 4,005,292. However, as

with the Centria system, no attempt has been mad in such systems to utilize such multichannel read-outs t provide early detection f erron ous substrates.

According to the present invention there is provided apparatus for analysis of liquids of the type which accepts disposable discrete analyte dedicated substrates and monitors the response of the substrates to applied analyte
 samples characterised in that testing means associated with the response measuring means includes testing means adapted to discard substrates which are inoperable due to a defect or being dedicated to a different analyte from that being measured.

The problems of the prior art devices are solved by obtaining a record of the initial and subsequent signals generated by the substrate, and this in turn is achieved by transferring the substrates directly to the read stations after the sample is deposited, without passing the substrate through intermediate, non-reading stations as is common in prior art analyzers. The use of multichannels avoids the delay in processing that would occur in a continuously monitoring single channel analyzer.

More specifically, in accordance with one aspect of the invention, such an analyzer is provided comprising a plurality of stations, each of which is constructed to receive a substrate bearing a sample for analysis; individual sensing means at each of the stations for detecting initial and subsequent sample responses of a received substrate; means for monitoring such responses at each of the stations; whereby continuous monitoring is obtained of changes occurring at all of the stations. One of the sensing and monitoring means includes at least one of the following: means for detecting the existence of equilibrium conditions in the substrate, defect test means for determining operability of the substrate for the analyte of choice, and discrimi-45 nating or testing means for discriminating between a substrate for one analyte and a

In accordance with another aspect of the invention, the analyzer comprises station

50 means for receiving a substrate capable of generating a response when contacted with analyte-containing sample and means for monitoring responses of the substrate contacted with the sample; the analyzer being improved so that the station includes means for detecting, after receipt of the substrate by the station means, the presence of an inoperable substrate, as herein defined, whereby the inoperable substrate can be discarded without 60 waiting for the completion of the analysis of that substrate.

substrate for a different analyte.

A preferred use of the inventi n is simultaneous detection of signals at multiple stati ns.
Therefore, in acc rdance with an thir aspect of the invention, there is privided a cintinu-

ously monitoring, multichannel analyzer for ion activity of sample bi logical liquids deposited on a substrate containing a pair of ion-selective electr des, the analyzer comprising a plurality of stations each of which is capabl of receiving a substrate for analysis; individual sensing means at each of the stations for detecting initial and subsequent potentiometric signals in the substrate generated by the sample, the sensing means including an electrometer; and monitoring means for monitoring the signal at each of said stations; whereby continuous monitoring is obtained of changes occurring at all of the stations.

The present invention will now be described by way of example with reference to the accompanying drawing in which:—

80

85

Figure 1 is a plan of an analyzer constructed in accordance with the present invention;

Figures 2 and 3 are perspective views of one embodiment of an arrangement of stations of the analyzer, only one station being shown for clarity;

90 Figure 4 is a perspective view of the interior of the station of Fig. 3, the cover plate having been broken away;

Figure 5 is a plan of the interior of the station of Fig. 4;

Figure 6 is an elevation of the pivot member of the station;

Figure 7 is a schematic view of a circuit useful in the station of the present invention;

Figures 8a and 8b are representative plots of the electrometer output and the first derivative of that output, respectively;

Figure 9 is a fragmentary elevation, partly schematic, in section of the stations and the loading and unloading means;

105 Figure 10 is a fragmentary plan of the transfer means useful in loading the stations;

Figure 11 is a fragmentary elevation in section of the means shown in Fig. 10;

Figure 12A is a fragmentary elevation in section of the metering station, taken generally along line XIIA-XIIA of Fig. 1;

Figure 12B is a fragmentary section taken generally on the line XIIB-XIIB of Fig. 12A;

Figure 13 is an elevation in section of means for supplying the slides to the transfer means, taken generally on line XIII-XIII of Fig. 1;

Figure 14 is a plan of another embodiment of the present invention; and

120 Figure 15 is a fragmentary elevation in section of one of the stations illustrated in Fig. 14.

Although the present invention is hereinafter described in connection with a multichannel, continuously monitoring potentiometric analyzer for reading ISE's, a preferred mbodiment, it is not so limited except where stated. Thus the present invention can also b applied t a continu usly m nitoring analyzer using multipl radiometric det ctors, pr fera-

bly ither photometers or fluorimeters or both, which read any suitable substrate incorp rating, for xample, reagents that create a dye in proportion to the analyte being measured, to provide early detection of a defective or erroneous reaction. Such reagents can be in solution or in the form of a dried coating.

As used herein, a "substrate" is the chemical or chemicals through which the analyte of 10 choice of a liquid sample generates a detectable response or signal. That is, a "substrate" is, in the case of colorimetric analysis, one or more reagents, and in the case of potentiometric analysis, one or both electrodes. As used 15 herein, an "inoperable substrate" is one that is either defective or erroneous i.e. unable to measure the analyte for which it has been selected.

In the case of potentiometric analyzers, the 20 substrate which makes the test possible comprises a supported pair of electrodes selective to the ion activity of choice; thus the name ion-selective electrodes or ISE's. Such electrodes, by the use of a salt bridge, permit the 25 generation of an electrical signal, in the presence of the sample test liquid, that is indicative of the test ion activity and thus the concentration, in a manner well known in the art. As used herein, "response" not otherwise 30 limited includes an electrical signal derived from paired electrodes, and also includes any detectable response of the substrate that is indicative of the level of analyte of choice.

Any generally planar form of the ISE's can 35 be used, preferably in pairs to permit a reference sample to be deposited along with the test sample. One convenient form, illustrated as a slide 10. Figs. 1 and 10, is that disclosed in Research Disclosure, Vol. 157, May 40 1977, Publication No. 15767, published by Industrial Opportunities Ltd., Homewell, Havant Hampshire PO91EF United Kingdom. Such a slide comprises, as best seen in Fig. 10, a frame 12 the bottom surface of which is 45 supportingly attached to a pair of ISE's 14 and 16 having a generally planar strip form, and a bridge 18 used to promote ionic migration between the reference sample and the test sample deposited over the electrodes. The 50 bridge is located in one opening 20 of the frame 12, and silver chloride coated surfaces of the ISE's are exposed in two openings 22 of the frame, for purposes of making readings as hereinafter described.

An analyzer constructed in accordance with the present invention can be designed to receive substrates for reading only after the test sample has contacted the substrate, or it can be design d to receive the substrates 60 before that vent, to be read "in blank." Th

form r situati n, shown in Figs. 1-13, pr ferably utilizes, in conjunction with an analyz r 30 n a platf rm 31, means 170 for transferring a substratt in the form of a slide 10 65 contacted with a sample directly to the analyzer, without passing through intermediate stations. Such an arrangement ensures that th analyzer 30 will sense the initial signal generated by the samples when they first contact the ISE's. The liquid samples can be deposited from containers C on to the ISE slide 10 by hand such as by any suitable disperser or metering slide 10 by hand or by any suitable dispenser or metering station 230, Figs. 1 and 12A. The slides 10 can be loaded on to transfer means 170 by hand or from a suitable supply means 280. Representative, useful mechanisms for station 230 and supply means 280 are discussed hereinafter.

80

The analyzer 30 comprises a plurality of stations each of which is provided with s nsing means for sensing responses or signals from the substrates (Figs. 2-5), comput r/monitoring means 166 to monitor or display the response sensed at each station (Fig. 1), and multiplexing means 160 for repeatedly switching the monitoring means to each of the stations (Fig. 1). As shown in Fig. 2, the stations can be a plurality of substantially identical compartments removably stacked in a frame 42, the frame being movably mounted for vertical displacement with respect to transfer means 170. A convenient mode for such displacement, Fig. 2, comprises mounting the frame 42 in a track 44 mounted on a stanchion 45 supported by a base 46. The back plate 47 of the fram is drilled and threaded, through which is pass d a rotatable lead screw 49. The screw is turned 100 by gears 50 and 52 and a motor 53. Each of the stations is preferably separately r m vably mounted, to facilitate repair or replacement, in frame 42 by opposed tongues 54 which fit into mating grooves 56 of the frame, Fig. 3. 105 A pair of removable, vertically extending stop plates, of which only the front plate 57 is

Preferably each station includes, for sensing 110 initial and subsequent signals of the slide 10 contained therein, contacts in this cas in the form of probes 60, one for each ISE, and an electrometer 120 wired to the probes, Figs. 4 115 and 5. As the stations are identical, one (32) will be described. The location of thr of the others is shown in Fig. 3 by dashed arrows labeled 33-35. Station 32 comprises a bottom wall 63, a cover plate 64 which is preferably removably mounted as by screws, front wall 65 and rear wall 66. The probes are disposed to project into a path 62 which the slide 10 follows through the stations, defined by entrance slot 67, bottom wall 63, guide walls 68 upstanding fr m bottom wall 125 63, and an xit slot 69, Fig. 3. Adjacent t slot 67, wall 63 is sloped upwardly and inwardly, Fig. 9, for asy loading. Prob s 60 are in the f rm of Z-shaped m mbers with 130 spaced serrations 70 at one end and stop

shown, Figs. 3 and 4, prevents the stations

from moving out of the grooves 56 during

operation.

flanges 71 at the ther end (Fig. 6). The Z-shaped members are held in place such as by screws 72 on a pivot member 74. Member 74 in turn comprises a base 76 and a central, upstanding shoulder 78 perforated at front portion 80 and rear portion 82. Base 76 features a pivot lug 84 journaled to guide walls 68 by a pivot pin 86, Fig. 9, at a distance sufficiently spaced above bottom wall 10 63 as to accommodate slide 10.

To bias pivot member 74 downwardly against a slide in position as shown in Fig. 9, a bias spring 90 is secured at one end to front portion 80 and at its opposite end to a link 15 plate 91 attached to an adjusting screw 92 mounted in front wall 94 of the station. The spring is selected with a spring constant sufficient to rotate member 74 about pivot pin 86 and to force serrations 70 through the 20 non-conductive silver chloride coating that is exposed at opening 20 of the slide and into contact with the conductive silver layer below (Fig. 9). By such means, probes 60 are constantly in contact with the electrodes of slide 25 10 to provide continuous read-out.

To raise probes 60 during loading and unloading of the slides, a release arm 100 is pinned at end 102 to portion 82 of the pivot member, Figs. 5 and 9. The opposite end 30 104 of arm 100 projects through opening 106 of rear wall 66, and terminates in handles 108. A solenoid 110 is disposed, Fig. 3, on arm 112 mounted on stanchion 45. The solenoid is provided with jaws 114 which 35 mate with handles 108 to withdraw the arm 100, causing member 74 to pivot away from

the slide against the action of spring 90. Stop

rods 116 are held in place in rear wall 66, by means such as nuts, to stop the pivoting of 40 member 74 (Fig. 9). Suitable conventional control means, not shown, are wired to the solenoid to activate it on command, and specifically at the time when a slide is to be moved in or out of the station.

The electrometer 120, Figs. 4 and 5, is preferably an FET type and can be disposed outside of guide walls 68 but within the compartment. The electrometer is connected via amplifier 121 and lines 122 to multiplexer 160, hereinafter described. Amplifier 121 can be any conventional type, such as FET (Figs. 5 and 7).

Preferably, each station has its own electrometer because classic conventional multiplex55 ers are unable to respond to low signal levels that are generated by the ISE's prior to the electrometer read-out. However, a single electrometer could be incorporated in monitor/computer 166 if a mechanical switching unit or some other or no multiplexer is incorporated to handle the signals from each station lacking an electrometer.

Additional circuitry for voltage and impedance test purp s s h reinafter described is 65 preferably disposed within each stati n 32,

Fig. 7 (not shown in Figs. 4 and 5), f r similar r asons. That is, internal impedances of multipl xers make impedance and voltage comparisons impractical unless th y are done prior t multiplexing. H wever, if such impedances are compensated for by computer logic, even the circuitry hereinafter detailed could be located downstream of multiplexer 160 rather than upstream.

70

95

75 One example of such test circuitry is a calibrating circuit 130 comprising a test voltage source 132, providing a voltage V, wired in series with a load resistor R. The calibrating circuit 130 can be closed by a double pole, double throw switch S, to the position B-B', Fig. 7. A double pole relay 136 can be used to short out source 132 by closing switch S<sub>2</sub> providing a zero value intercept. The electrometer's reading of a voltage nominally equal to "V" and a shorted voltage Eshort nominally equal to zero allow the computer, combined with monitor means 166, to calibrate itself. That is, an electrometer reading E<sub>132</sub> of the nominal voltage V<sub>132</sub> creates a correction factor  $k = V_{132}/E_{132}$ . Thereafter, the actual potential Vunknown developed by the substrate under test can be determined by the following equation:

## $V_{unknown} = k(E_{unknown} - E_{short})$

wherein E<sub>unknown</sub> is the reading of the electrometer for the test in question.

Still further, relay 136 can be oppositely activated to close switch S, activating a defect test circuit 140 comprising resistors R2 and R3 and switch S4 in series with probes 60. The function of this circuit is to ascertain in general the operability of the substrates selected 105 for the test. More specifically, in the case of ISE's the circuit is intended to determine the internal impedance of slide 10 and thus whether the coatings of the ISE's of slide 10 are inoperable. This is done with switch S<sub>1</sub> closed to place electrometer 120 in parallel with circuit 140. Switch S, is then closed t place R2 or R3 in the circuit. R2 and R2 become voltage dividers, and the voltages thereacross are in part controlled by the internal impedance of the slide. By selecting the 115 value of R2 and R3 to give a predicted ratio of electrometer readings E(open) to E<sub>R2</sub> or E<sub>R3</sub> within a fixed value, for example between about 0.5 and 1.5, the internal impedance can be checked. Useful values for the resistors include R2, for potassium ion determination, equal to above 10 M ohms, and R<sub>3</sub>, for chloride ion determination, equal to about 500 K ohms. These values are based on the 125 fact that typical ISE's for potassium ions have impedances Z betw en about 5 megohms and 75 megohms and for chlorid ions, Z, between about 50 K and 130 K hms.

Conv ntional comparat r circuit compo-130 nents, not shown, can b used to make the

determination whether the slide is chlorid in or potassium in sensitive, by comparing the ratio of E<sub>open</sub> and E<sub>R2</sub> or E<sub>R3</sub> against a stored constant, and E<sub>open</sub>/E<sub>R2 or 3</sub> against the same 5 or different constant, within a suitable range such as the one noted above. Any reading outside of the set range is indicative of a defective coating on one or more of the electrodes, and the slide is discarded. Switch S4 is 10 of course appropriately selected to R<sub>z</sub> or R<sub>3</sub>, depending on which ion is being checked at

If, on the other hand,  $E_{R2}$  or  $E_{R3}$  is equal to zero initially, and the first derivative of Eno or 15 E<sub>R3</sub> is approximately equal to zero as explained below, then the paired electrodes of slide 10 are shorted together as a pair and again the slide must be discarded.

By these means, circuit 140 becomes a 20 discriminator circuit which determines, for slides 10 having impedances that are not equal to zero, whether the slide is suitable for measuring chloride ions or whether it is suitable for measuring potassium ions. The impe-25 dance value must be comparable to that expected for the desired test, or the computer will register a "failure" due to inoperability, and a new slide 10 is automatically selected for remetering from the sample container still 30 at station 230.

To provide a means of ascertaining equilibrium conditions in the substrate, a circuit to ascertain the rate of change of the signal is included. A preferred form of such a circuit is 35 a conventional differentiator circuit 148, comprising an amplifier 150, such as an FET type, capacitor 152, and resistor  $R_{\scriptscriptstyle S}$  in parallel with the amplifier 150, Fig. 7. Such a circuit preferably is located between multiplexer 160 40 and monitor/computer 166, as shown, or it can be included as a component of each of stations 32-39. It is useful in ascertaining an equilibration in the initial signal, prior to loss of source of sample at the metering station as 45 hereinafter described. That is, since the voltage values detected by the electrometer with S, in the left hand position, Fig. 7, could be caused by a shorted pair or by the condition

#### activity unknown = activity reference fluid. 50

a derivative not equal to zero will be indicative of the latter and the slide need not be discarded. Furthermore, continuous monitoring 55 of the first derivative allows monitor 166 to determine when equilibration is complete and equilibrium is reached, so that the final reading can be taken. Some slide constructs may require longer equilibration tim than thers, 60 and circuit 148 ensures that the time at which quilibrium conditions are reached, will be detected for ach slide. Thus, each slide will b retained in its stati n only long en ugh to obtain a stable reading. Alternatively, the circuit 148 c uld be located in m nit r/c mputer 166.

Th plots shown in Fig. 8a and 8b illustrate the usefulness of the diff rentiator circuit. The electrometer reading of zero at time t,, Fig. 8a, could mean a shorted pair of electrodes. However, circuit 148 detects that the first derivative at time t, is not zero, Fig. 8b, so that the short can be ruled out. Such timevarying signals, are to be expected for s me 75 initial period of time for the ISE's describ d. Although the electrometer reading continues to fluctuate until time t3, the detection of a zero first derivative at time t3 is indicative that a stable equilibrium condition has been reached and the final reading can be taken.

A conventional second derivative diff rentiator circuit, not shown, can be added at point A, Fig. 7, to discriminate a momentary dE/dt = 0, at time  $t_2$ , from the actual equilib-85 rium conditions at time t3. Alternatively, computer 166 can require more than one first derivative reading to be equal to zero, to distinguish from the nonequilibrium condition existing at time t2.

Stations 33-39, not shown, are substantially identical to that described for station 32.

90

100

It will be readily appreciated that the stations should each provide an electrical shi ld. Preferably this is achieved by constructing 95 walls 63, 65, 66, cover plate 64, and the exterior side walls from a grounded conductive material, such as copper. The rest of the stations, such as guide walls 68, can be nonconductive materials such as plastic.

To maintain a uniform temperature for the compartments, frame 42 can be cooled by suitable means, for example, passageways 154 which extend above (Fig. 9), bel w and between the compartments. These carry a 105 liquid for heat exchange. The liquid can be brought in via inlets 156 and removed via outlets 158 (Fig. 3).

Lines 122 extend from each station through a grommet 159 (Fig. 5) and opening on wall 110 66 and are connected to multiplexer 160. Figs. 2-3, shown as being mounted on fram 42. Alternatively, multiplexer 160 can b fixed to an immovable support, for example, base 46. A line 162 connects from outl t 115 posts 164 of the multiplexer to computer/monitor 166 (Fig. 1). Any conventional multiplexer can be used, such as the Datel Model MM8 Multiplexer, manufactured by Datel Systems. Inc. Although multiplexing, technically 120 speaking, is well known to be a nonc ntinuous transmission of individual signals arising from the repeated switching to each of several broadcast sources, such switching occurs at such a rapid rate that, practically speaking. continuous rading feach stati n 32-39 is 125 achieved. Thus, typical delays b tween each reading of station 32, for xample, are on the ord r f 1 millisecond, compared t a much

slower signal change rate, gen rated by the

130 substrate, of about 1/6 of a milliv It per

sec nd. Th millisecond delay is more than ampl to detect such a signal change through th differentiator circuit 148.

Computer/m nitor 166 can b f conven-5 tional construction, including on its face appropriate dials, gauges or other indicators 168. A keyboard, not shown, can be added for ease in control. The programming of such a computer can be by means of hardware or 10 by an appropriate program, as is well known. A variety of microprocessors are available in the art for such purposes. Alternatively, only a monitor 166 can be included, the control of the apparatus being provided by a general 15 purpose computer, not shown.

As alternatives to the use of a multiplexer, the signals from each station 32 can be fed directly and continuously (not shown) into a monitoring means comprising a dedicated dial 20 or indicator such as indicator 168, Fig. 1. Or the monitoring means can comprise a single indicator 168 and a manual switch (not shown) which selectively connects in a conventional manner any of the station responses 25 to the indicator for a selective reading of such responses. Such alternatives are more desirable if only a few stations are utilized.

As shown, monitor/computer 166 preferably includes differentiator circuit 148, but not 30 the electrometer or any of the test circuitry illustrated in Fig. 7. However, with appropriate adjustments as mentioned above, it is contemplated that monitor/computer 166 could include such circuitry, so that the sens-35 ing means of each station 32-39 includes only the probes 60.

Circuitry similar to that described above can be used in stations 32-39 to detect radiometric signals, except of course without an elec-40 trometer 120 and its calibrator circuit 130. In such a case, a photocell detects light reflected from or transmitted through the substrate inserted into path 62, and the differentiator circuit, if it detects a zero first derivative after 45 a suitable initial time increment, will indicate that no reaction is occurring or is occurring at the wrong wavelength. Such results are indicative that the substrate is defective or erroneous and must be discarded without waiting for 50 completion of the test.

As suggested above, it is important that the initial signal generated by the sample on the substrate, whether a measure of a potential or a density change, be detected by the analyzer 55 to determine if the substrate must be discarded and a new one used, or if the substrate is properly functioning and can be retained. By such a procedure, if a new substrate is needed, the same container C of 60 sample can be used to deposit a fresh sample on that new substrate, since that contain r can b left in the metering position at stati n 230 (hereinafter described) for the short length of time the initial reading r quires. 65 How ver, t prev nt undu d lay in th pre-

sentation of a n w s rum sample at station 230, it is preferred that the initial reading be taken as so n as possible. It has b en found that a useful time limit is 30 sec nds after th sample initially contacts the substrate. This time is sufficient for a computer decision to be made concerning the substrates, and is not long compared to the total processing tim . Thereafter, if a "go" signal is generated by the test circuits, the container C from which the sample was taken can be moved out of the metering position at station 230 to a discard station, not shown. To insure that an initial reading is obtained, the substrate with the sample on it is placed within the analyzer directly after the sample is deposited. As used herein, "transferring directly" means transferring without proceeding through an intermediate processing station. Preferably such direct transfer takes place within 30 seconds from the time the sample is deposited on the slide.

Such a direct loading can be done by a transfer means 170, although loading can also be done by hand. Such a means can b constructed, Figs. 10 and 11, to comprise an arm 172 mounted on a rotatable platform 174 fixed to a drive shaft 176 driven by gears 178 and 180, and motor 182. Within arm 172 is reciprocated a pusher element 184 guided between tracks or ways 186 and 188. Each track is appropriately recessed at 190 to accommodate both the pusher element 184 and a slide 10. Springs 192 and 100 194 serve as a gripping means to temporarily retain the slide in arm 172. To reciprocate element 184 in the tracks, a two-member crank 196 is eccentrically journaled to element 184 at end 198, and at its opposite end 200, to a drive shaft 202 driven by motor 204.

Motor 182 is activated to rotate arm 172 into a position aligned with slot 67, Fig. 9. Then motor 204 is activated so that crank 110 196 causes pusher element 184 to eject the slide 10 out of tracks 186 and 188 into slot 67.

105

Transfer means 170 also serves to provid nonsequential access of the substrates to stations 32-39 as soon as computer/monitor 166 identifies a station that can be used. That is, slides can be removed from stations 32-39 by means of incoming new slides pushing out the "finished" slides through slot 120 69. A conveyor belt 206, shown in phantom, Fig. 9, can be used to remove and discard such "finished" slides. Such use of transfer arm 172 and an incoming slide 10 to eject the old slides depends, as noted, on a computer-generated signal that the old slide has reached equilibrium and that a final reading has been tak in. Since such conditions can vary from slide t slide, th vertical movement f frame 42 past transfer arm 172 all ws 130 nonsequ ntial selecti n of the first station

ready to be occupied by a new slide.

Alternatively, a separate unloading mechanism 210 can be utilized at a level 211 which is different from the loading level of arm 172, permitting unloading to occur separately from loading. Such a mechanism can comprise a pusher arm 212 secured to a pin 214 having flanges 216 mounted between tracks 218, of which only one is shown, Fig. 9. Pin 214 is 10 journaled to a crank 220 at end 221, the crank being secured at its other end 222 to a pivot 224. Intermediate the crank ends, the crank accommodates a roller 226 in a slot 228, eccentrically mounted on the rotating 15 face of motor 229.

To deposit a test sample and a reference sample on slide 10 automatically, a metering station 230 is preferably included. Such a metering station includes, Figs. 1 and 12A, a 20 turntable 232 provided around its rim with apertures 234 which accommodate containers C. Such containers conveniently have the form of a cup, and to provide accurate dispensing of stable, pendant drops the cup 25 preferably includes an apertured platform 240. Such as apertured platform can be constructed as described in Research Disclosure, Vol. 133, May 1975, Publication No. 13360, published by Industrial Opportunities Ltd., Ho-30 mewell, Havant, Hampshire, PO9,1EF, UK, so that a fixed, predictable drop volume, such as 10 microlitres. is formed when the liquid in the container is pressurized by means such as hose 242, even when the properties of the 35 liquid vary from patient to patient. Hose 242 is located at a metering frame 244, Fig. 1, which mounts a separate dispenser tube 246, Fig. 12B, for dispensing a similarly sized drop of reference fluid having a known concentra-40 tion of the ion being analyzed. Because the reference fluid is always the same, it is not necessary that tip 248 of tube 246 be constructed with the same features as platform 240, although it can be.

To permit dispensing when cup 234 is in position in the frame 230, the platform 232 is raised, arrow 247, Fig. 12B, by moving means 249, Fig. 12A, such as a hydraulic piston, to dispose the cup in position under 50 hose 242. At the same time, platform 232 moves past stationary tube 246 by reason of platform aperture 250, Figs. 1 and 12B. The drops shown in Fig. 12B are formed by pressurizing hose 242 and tube 246.

To touch off the pendant drops onto slide 10, arm 172 is raised an appropriate distance, arrows 252, until the slide contacts the drops, but not so far as to contact the slide to tube 246 or platform 240. A suitable mecha-60 nism to achi ve this acti n comprises the mounting of shaft 176, Fig. 11, for recipro al moti n in platform 31. Preferably, a coller 254 is fixed to the shaft and an ecc ntric 256 is coupled to the c llar and activated by motor 65 258 t raise platform 174 and arm 172 at

the appr priate time.

85

Th indexing of tabl 232 is achiev d by a motor 260 activated by comput r/monitor 166. Preferably, the computer 166 is programmed to delay any advance of mot r 260 until the initial response is detected, i.e., the tests described above have indicated that th substrate is operative for the analyte f choice, however long such delay might take.

Alternatively, the advance of the turntable can be delayed 30 seconds by a delay circuit, Fig. 12A, which can comprise a limit switch 262 which alerts computer 166 that dispensing has begun, and a conventional 30-second 80 timer 264 which delas the signal from the computer to motor 260. This permits the initial reading of the substrate as noted above. before the sample container from which the sample was taken is moved away from stati n 230.

Blank slides 10 can be inserted into arm 172 by hand, or, preferably, by an aut matic supply means 280, Fig. 13. Such a m chanism comprises a turntable 282 driven by a rotating shaft 284, gears 286 and 288, and motor 290. The turntable carries a plurality f cartridges 292 removably confined within housings 294 spaced around the circumference of turntable 282. Each cartridge c ntains a stack of the slides 10 appropriate t the test to be run, the slides of any given cartridge all being specific for the same test. An ejector 300 is mounted below turntable 282, and is constructed similarly to unloading mechanism 100 210. That is, a pusher arm 312 is connect d to a pin 314 which rides in a track 318 as directed by a crank 320 pivoting at 324 and driven by a roller 326 and motor 329. Arm 312 slides into a slot 330 in cartridge 292 to 105 eject a slide 10 out exit slot 332 into th waiting transfer arm 172. Arm 312 is then withdrawn, and either another slide fr m the same cartridge, or a slide from another cartridge, is pushed out by arm 312 when trans-110 fer arm 172 returns to pick up another slid . As will be apparent from the preceding, the

operation of the aforedescribed apparatus is in the reverse order from that in which the stations were described. That is, supply 115 means 280 is first activated to eject a blank slide from its cartridge 292 into transfer arm 172. Arm 172 is rotated counterclockwise, Fig. 1, until the blank slide is positioned under metering frame 244 of metering station 120 230. At the same time, turntable 232 is rotated until container C of choice is positioned under hose 242, and aperture 250 under tube 246. The pendant drops are formed and arm 172 is raised to touch off the drops. Arm 172 is I wer d, and is rotated further until aligned with slot 67 f ne of th stati ns 32-39. During the slide and sample dispensing, analyzer 30 indexes frame 42 up or down screw 49 until the appropriate station

130 is at the level of arm 172 when it arrives with

a new slide bearing d p sited test and reference fluids. Motor 204 is activated, and pusher lement 184 ejects the slid into th station of the analyzer, preferably within 30 seconds from the time the drops were touched off onto the slide. As the slide advances into the compartments of that station, arm 100 is pulled to raise probes 60, and released when the slide is in the position shown, Fig. 9. The 10 defect test circuit 140 is activated, and the first derivative is considered to be certain the substrate is not defective or erroneous as to type. If the substrate must be replaced, immediately a new slide is dispensed by supply 15 means 280, a sample drop is dispensed onto the new slide at station 230 from the same cup as before, and the old slide is discarded or replaced by the new one. If the substrate is found to be satisfactory, turntable 23 can 20 index to a new cup C or deposit the same sample in the same cup on a different slide, for a different ioh concentration. The first derivative continues to be measured until an appropriate zero derivative value is reached, at 25 which time a final reading is taken by the electrometer and the slide can be discarded.

Appropriate control circuitry, not shown, can be used to insure that the aforedescribed machine functions are followed in their neces-30 sary order. For example, conventional limit switches can be positioned to detect completion of a movement which is a condition precedent. An optical detecting circuit can be used, including a light source, not shown, on 35 arm 350, Fig. 2, positioned to detect slot 67 and thereby initiate a command that designates that the indexing of frame 42 to the station 32-39 of choice is completed.

Figs. 14 and 15 illustrate an alternate em-40 bodiment wherein the substrate is read "in blank" at the several stations of the analyzer before any fluid is deposited by the metering station, as well as afterwards. Parts similar to those previously described bear the same ref-45 erence numeral to which the distinguishing suffix "a" has been applied.

As in the previous embodiment, slides 10a are dispensed by a supply mechanism 280a comprising a turntable 282a, a plurality of 50 cartridges 292a, and an ejector, not shown. Samples are metered from a metering frame 244a at dispenser station 230a, again using a turntable 232a bearing sample cups C. Unlike the previous embodiment, however, stations 55 32a, 33a, etc. are disposed on a turntable 400 which replaces the transfer means 170 of the previous embodiment, turntable 400 being the means by which each slide, now in a reading compartment, is moved into posi-60 tion at the metering stations 230a. Each stati n 32a, etc., such as station 32a, Fig. 15, has all the circuitry, probes 60a and prob release arm 100a as described before, xcept

that in addition an additional switch S. 65 shown in phantom, Fig. 7, is needed, along

with a dispensing slot 402 form d in compartm nt c v r plate 64a t receive the sample and r ference drops. To complete the electrical is lation f compartment 32a, pivoting metal doors 404 mounted on spring-biased rods 406 can be disposed in slot 402 to b pushed out of the way by dispensing tube 246a and the sample cup, not shown. Preferably platform 232a moves up for dispensing in the manner shown for the previous embodiment, Figs. 12A and 12B, as does turntable 400 to cause touch-off of the drops. Since the slides cannot pass completely through turntable 400, discarding is achieved by a pusher element 410 mounted on a track 412 and activated by a crank 414 under the compartment, which ejects the "finished" slide out the entrance slot 67a through which it came.

This arrangement permits the substrate or slide 10 to be tested with no sample present. Such tests include the "short" test obtained by reading the electrometer when S<sub>1</sub> is in position C-C' and S<sub>1</sub>' is closed to connect voltage source 132 to the ISE's. If the reading is not equal to the nominal zero value obtained by thereafter closing S2 to short out voltage source 132, then no short exists. If a short does exist, the slide is immediately discarded in favor of a new one even before the compartment is rotated into position under metering frame 244a, saving sample which is otherwise lost if a defect is discovered after sample has been metered or dispensed.

An incubator 420 can also be provided. 100 Fig. 14, into which the compartments 32a, etc. are rotated. This construction can obviat the need for heating or cooling tubes in the compartment, shown as tubes 1,54 in Fig. 9.

#### 105 CLAIMS

1. Apparatus for analysis of liquids of the type which accepts disposable discrete analyt dedicated substrates and monitors the respone of the substrates to applied analyte samples characterised in that testing means associated with the response measuring means includes testing means adapted to discard substrates which are inoperable due to a defect or being dedicated to a different analyte from that 115 being measured.

Apparatus as claimed in Claim 1 which includes a plurality of stations, each of which is constructed to receive a substrate bearing a sample for analysis, and each of which is 120 adapted to discard substrates which are ino-

perable.

3. Apparatus as claimed in Claim 2 which includes means for mounting the substrates one above another in a stack; individual sensing means at each of the stations for sensing initial and subsequent sample responses of a liquid analyte contacted substrates; transfer means for ins rting and r moving the substrates into and ut of any on of the stations 130 in r sponse t th sample resp nses s nsed

by the sensing means; m ans for moving the stack vertically with respect t the transfer means; and testing means for monit ring the sample responses at the stations; whereby any 5 one of the stations can be unloaded and reloaded immediately on detection of a response by the testing means indicative of an inoperable substrate.

4. Apparatus as claimed in any of the 10 Claims 1 to 3 in which the testing means is capable of detecting a zero rate of change of the sample response of a liquid analyte contacted substrate and initiating its discard.

5. Apparatus as claimed in any of the 15 Claims 1 to 4 in which the response measuring means is a colorimeter or fluorimeter and the substrate responds radiometrically to a liquid analyte sample.

6. Apparatus as claimed in any of the 20 Claims 1 to 4 in which the response measuring means is electrical and measures to potential of the substrate which is a pair of ion selective electrodes.

7. Apparatus as claimed in Claim 6 in 25 which the testing means associated with the response measuring means measures the impedance of the ion selective electrode.

8. Apparatus as claimed in Claim 7 in which the testing means initiates discarding of 30 the substrate if its impedance is substantially zero.

Apparatus as claimed in Claim 8 in 9. which the testing means includes a resistor connected in parallel with the ion selective 35 electrode having a resistance value less than the minimum impedance of the ion selective electrodes.

10. Apparatus as claimed in Claim 7 in which the testing means is capable of discrim-40 inating between at least two different ion selective electrode impedances.

11. Apparatus as claimed in Claim 10 in which the testing means is capable of discriminating between the impedance of a chloride 45 ion selective electrode and a potassium ion selective electrode.

12. Apparatus as claimed in Claims 10 or 11 in which the testing means includes a resistor having a resistance value between 50 that of the impedance of the two ion selective electrodes.

13. Apparatus as claimed in Claim 1 and as herein particularly described.

Printed for Her Majesty's Stationery Office by Burgess & Son (Abingdon) Ltd.—1979. Published at The Patent Office, 25 Southampton Buildings London, WC2A 1AY, from which copies may be obtained.